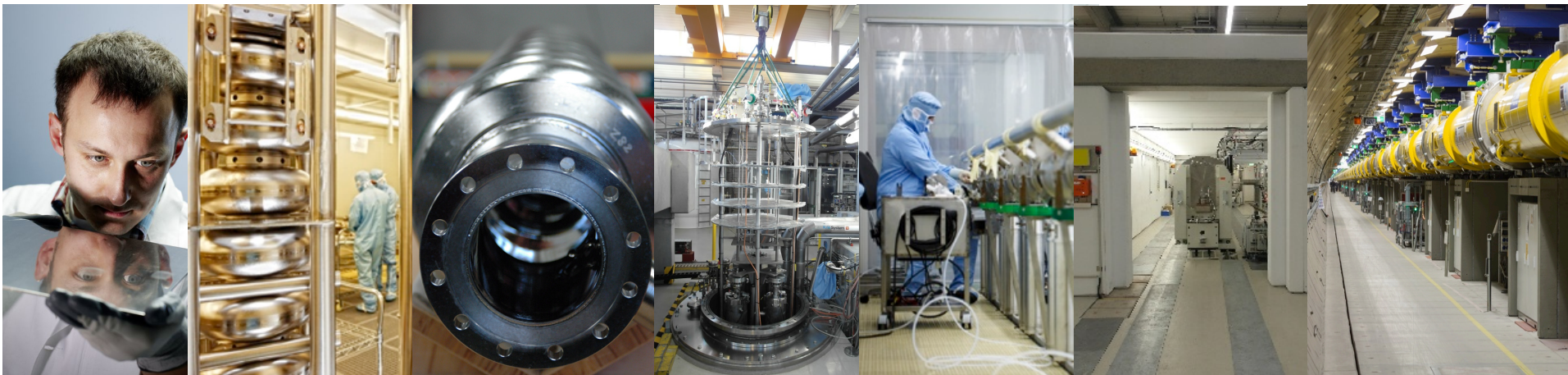


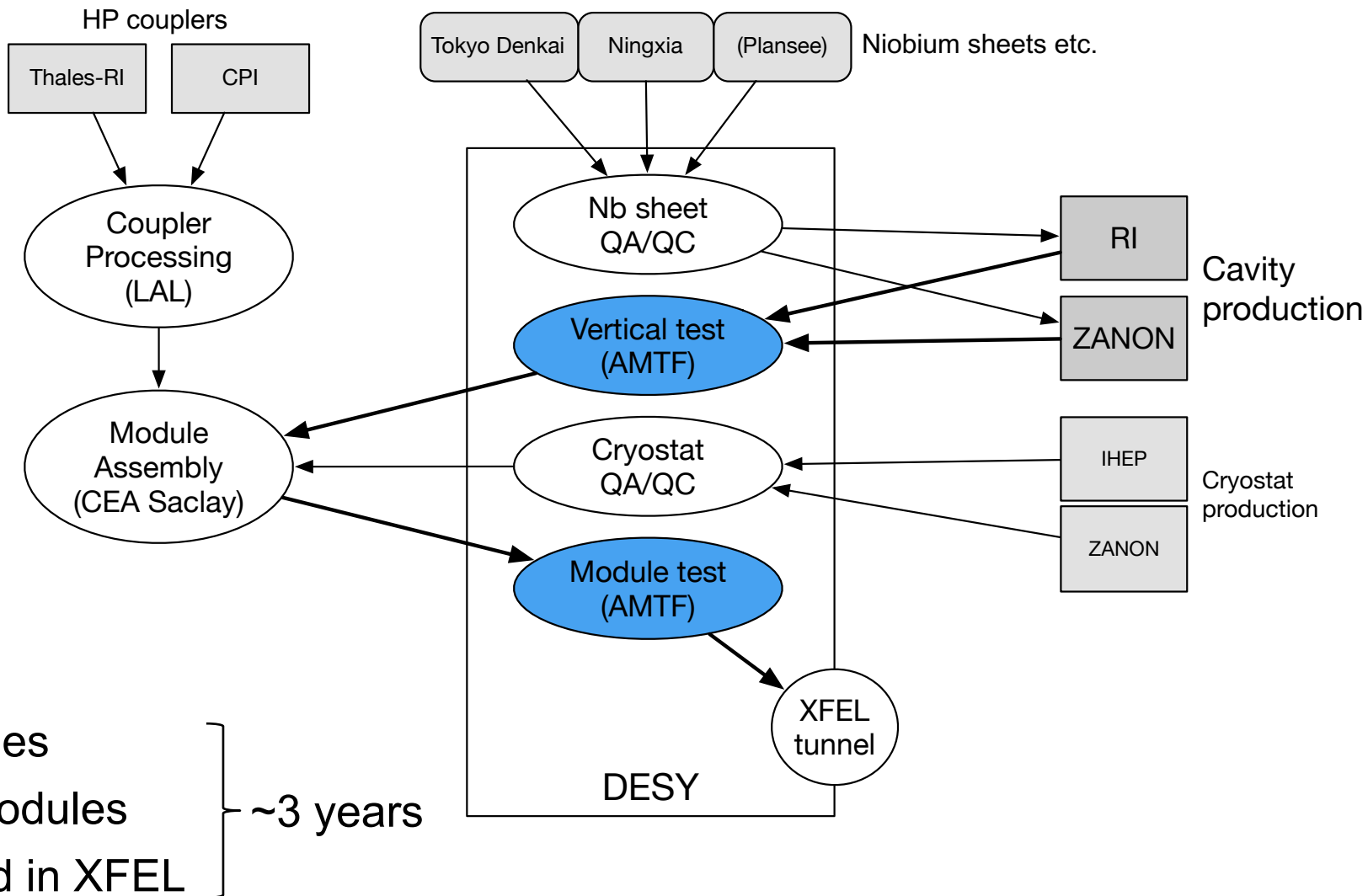
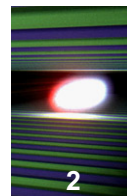
European XFEL, lessons learned, a stepping stone to a linear collider

Nick Walker (DESY)
for the XFEL team

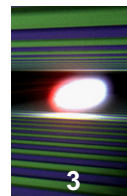
GARD SRF 2017 workshop, FNAL, 9.02.17



Process overview



Cavity Production (EZ, RI)

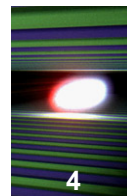


3

Entirely produced
by industry and
delivered “ready
to go”



Cavity Production (EZ, RI)



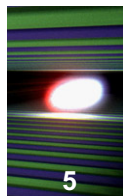
4

Entirely produced
by industry and
delivered “ready
to go”



Lesson learned #1: Yes you can do this and it worked really well

Cavity Production (EZ, RI)



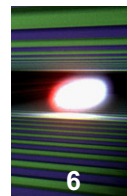
Entirely produced
by industry and
delivered “ready
to go”



Lesson learned #1: Yes you can do this and it worked really well

Lesson learned #2: Be prepared to invest a lot of effort into making
it work

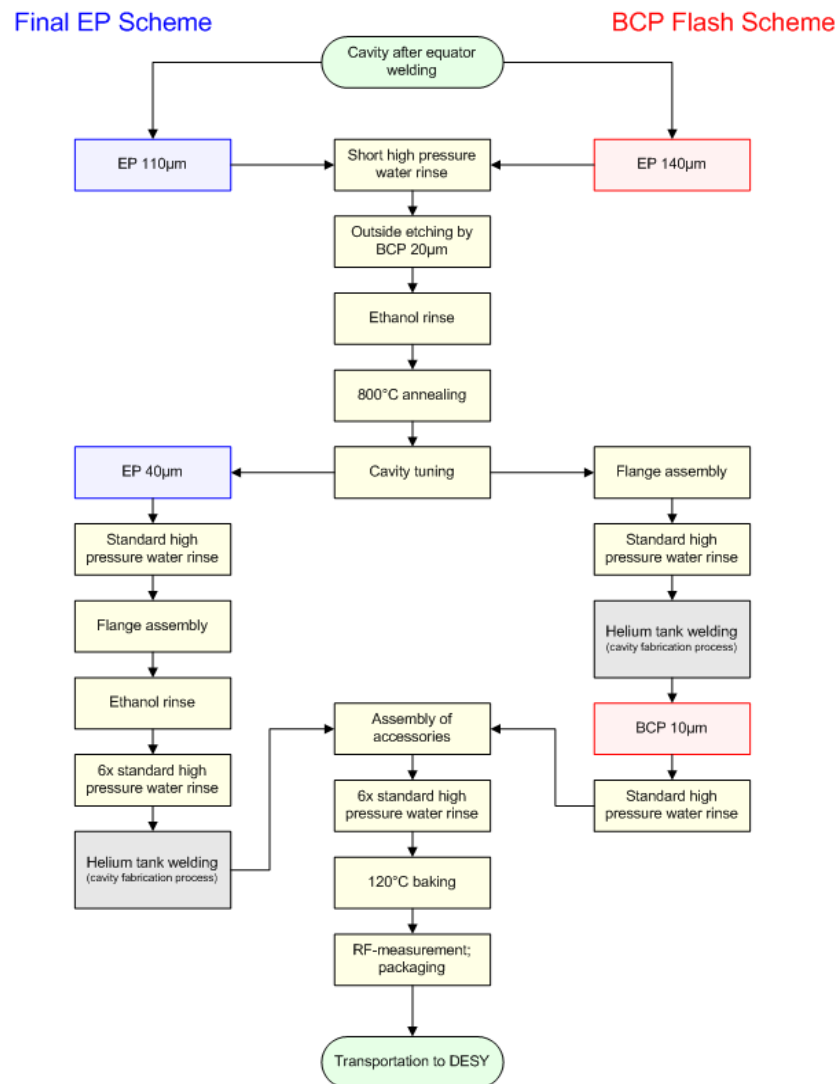
Cavity surface preparation



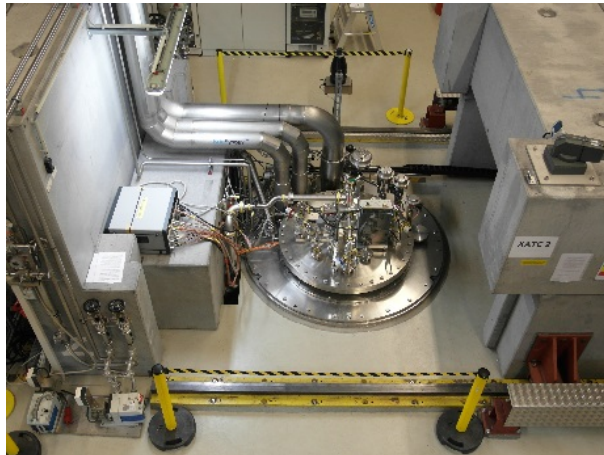
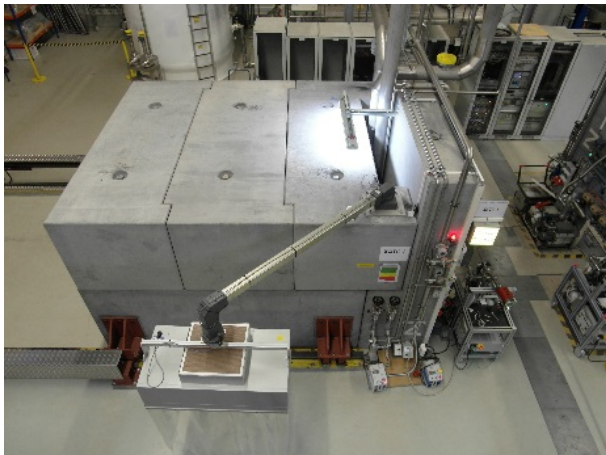
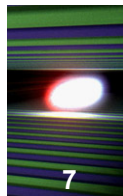
- Well-established process
 - >15 years R&D

- Two 'final' surface preparation methods:
 - RI: Final EP
 - EZ: Flash BCP
 - Vendor decision

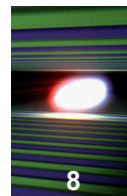
- LC TDR baseline is Final EP



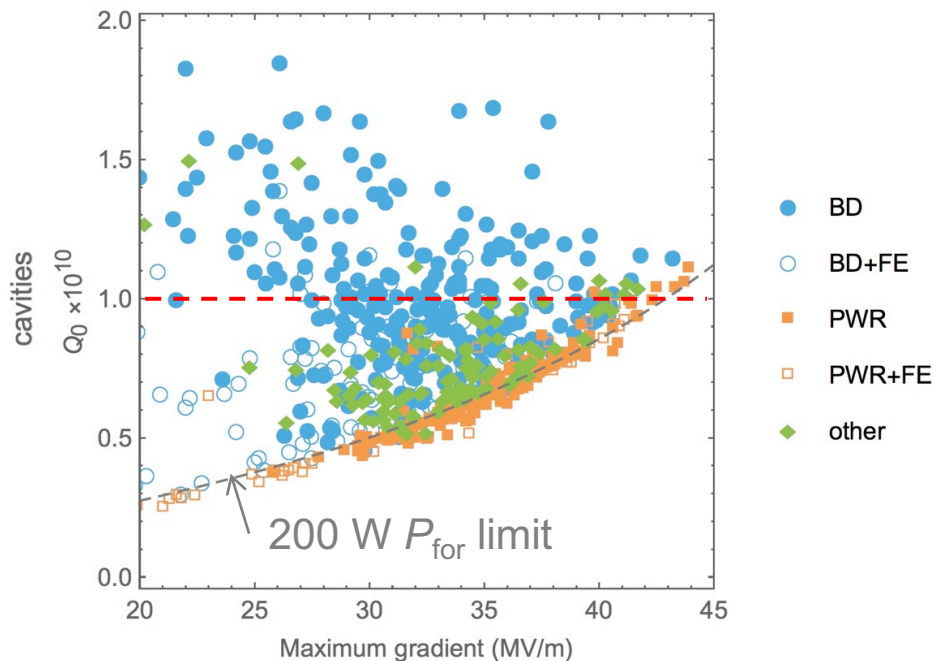
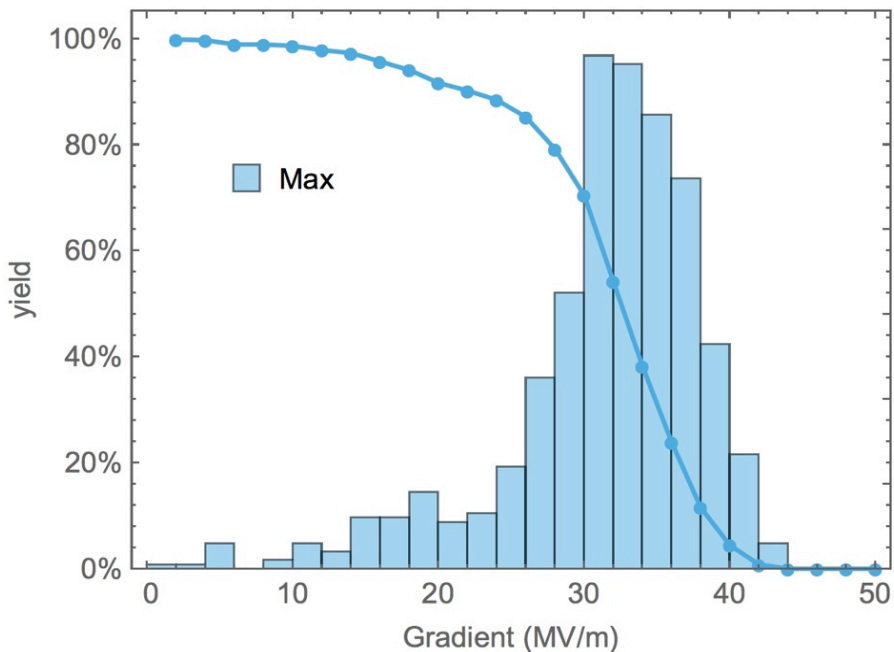
Vertical tests at AMTF



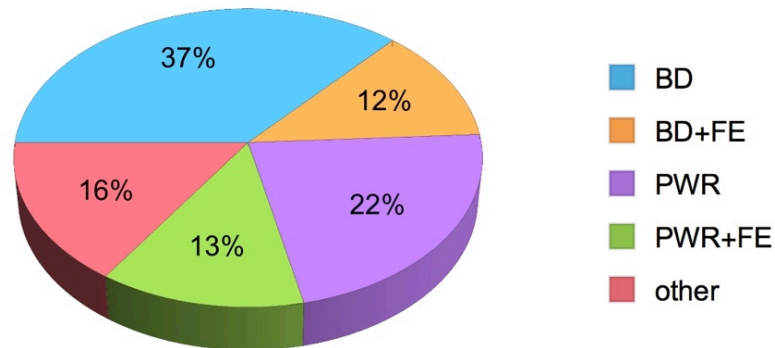
As Received Maximum Gradient in the VT



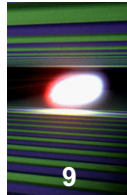
typical individual error: 10%



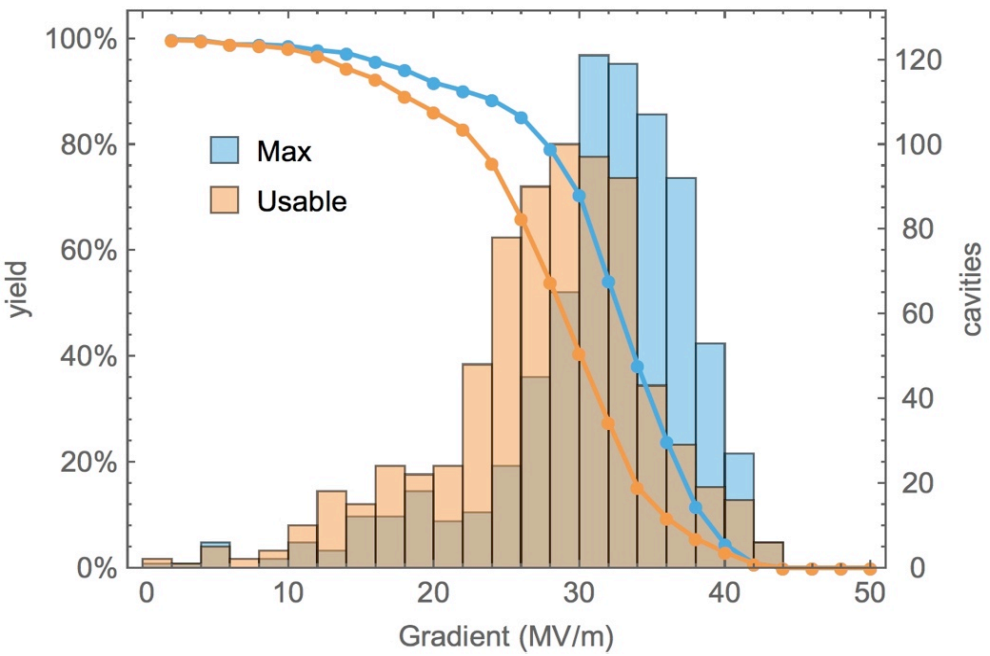
	Max
Number of cavities	745
$\langle G \rangle$ [MV/m]	31.4
σ_G [MV/m]	6.8
$\langle G \rangle_{G \geq 28}$ [MV/m]	34.1
Yield @20	92%
Yield @28	79%
Yield @35	31%



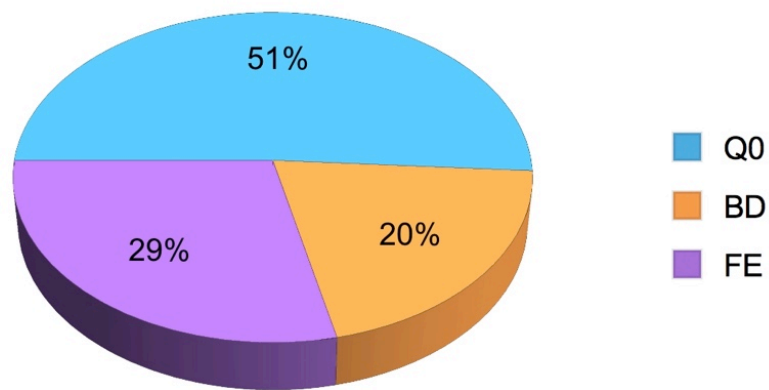
As Received Usable Gradient in the VT



typical individual error: 10%

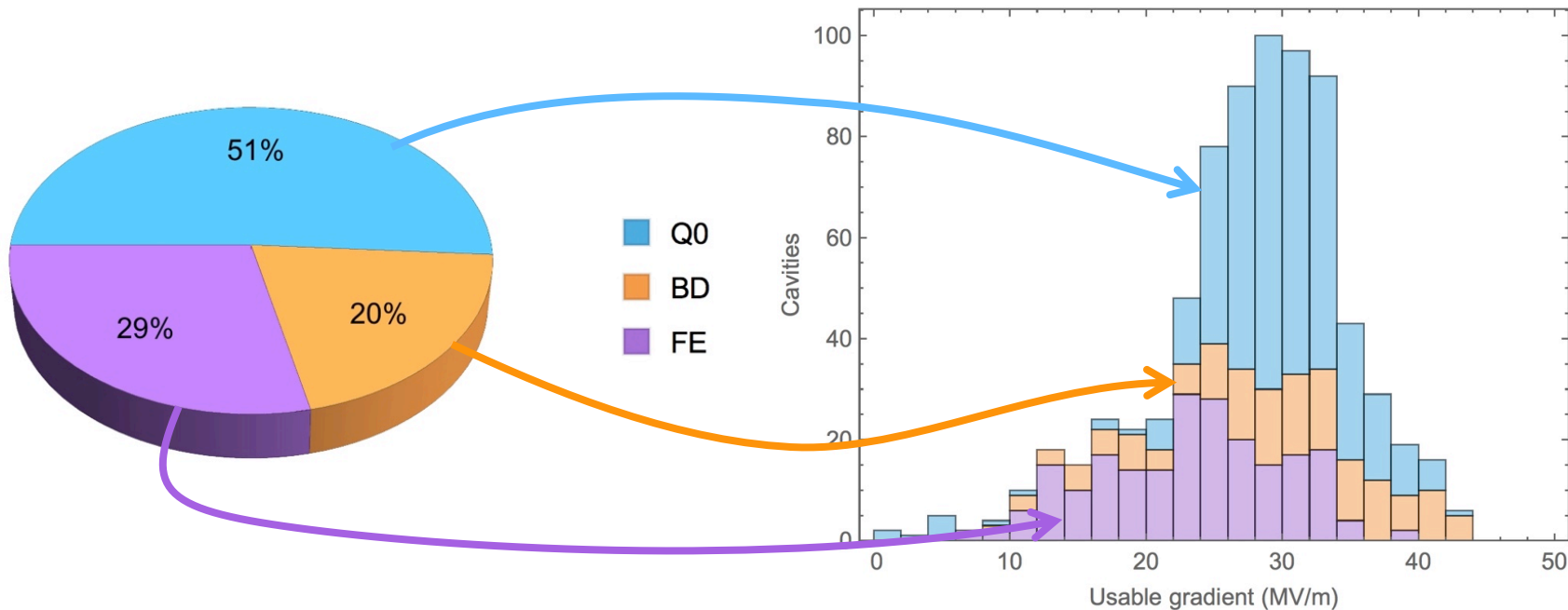
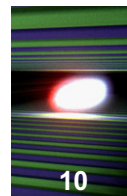


- Include operations spec
 - $Q_0 \geq 1 \times 10^{10}$
 - FE threshold (X-ray)
- Usable Gradient



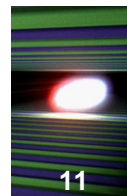
	Max	Usable
Number of cavities	745	745
$\langle G \rangle$ [MV/m]	31.4	27.7
σ_G [MV/m]	6.8	7.2
$\langle G \rangle_{G \geq 28}$ [MV/m]	34.1	32.8
Yield @20	92%	86%
Yield @28	79%	54%
Yield @35	31%	12%

Usable gradient: limiting effects

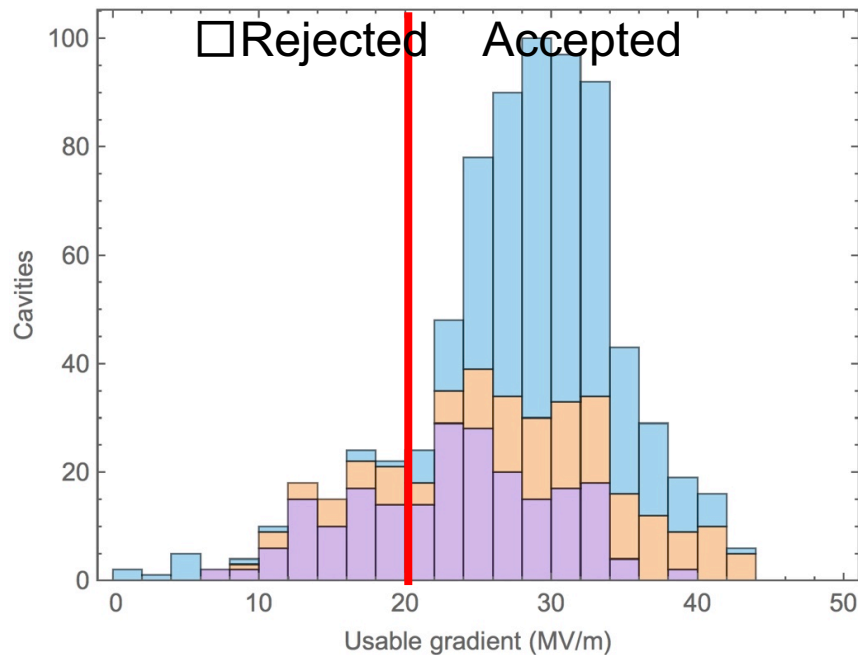
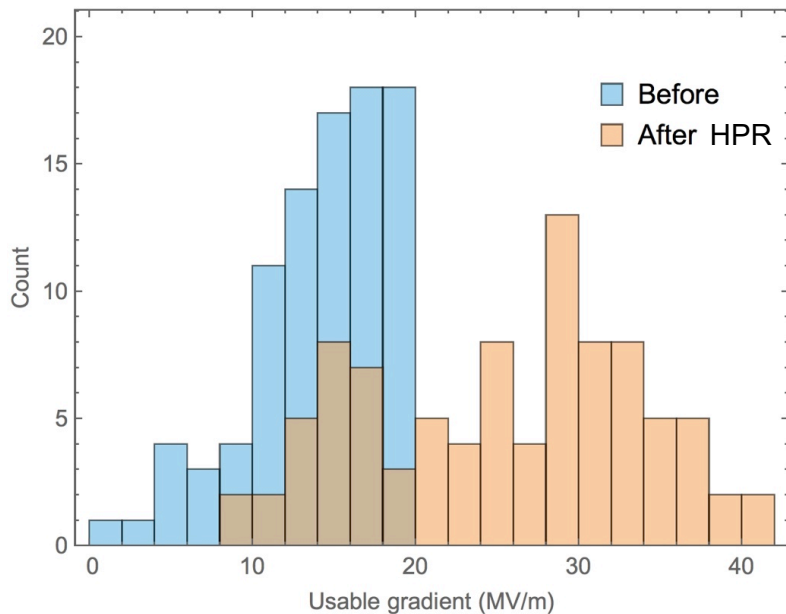


- Q_0 dominates at higher gradients (high-gradient Q-slope)
- Field Emission (FE) dominates <24 MV/m
- Quench (BD) not dominant –mostly higher gradients

Recovering low performance cavities



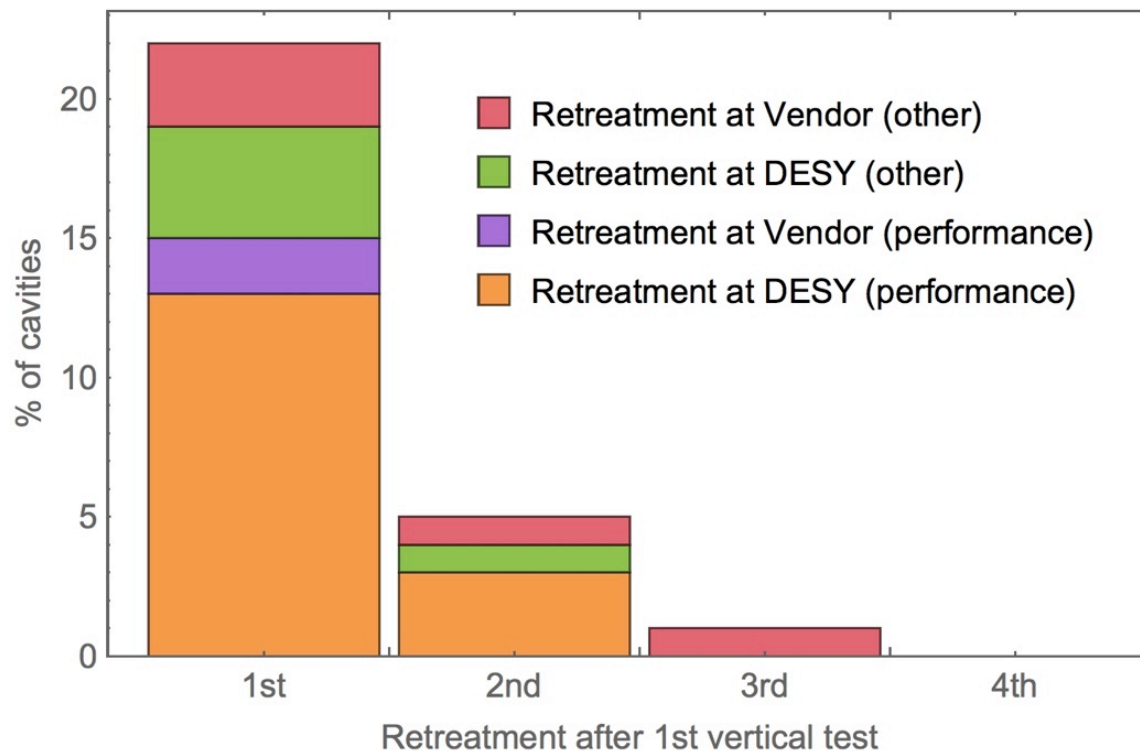
- $E_{\text{usable}} < 20$ MV/m rejected
 - Approx. 15% cavities
- Sent for surface retreatment
 - Mostly High Pressure Rinse (HPR)
 - Small fraction Buffered Chemical Polishing (BCP) and/or “grinding”



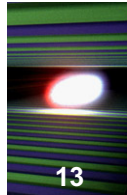
		Max	Usable
Average	MV/m	31.4	27.7
RMS	MV/m	6.8	7.2
Median (50%)	MV/m	32.5	28.7
Yield ≥ 20 MV/m		92%	86%
Yield ≥ 26 MV/m		85%	66%

Number of retreatments after the 1st vertical test

- Approx. 22% of cavities had ≥ 1 retreatment
 - ~15% performance-driven
 - ~7% due to vacuum- and mechanical-related problems (mostly HPR)
- 5% had 2 or more retreatments.
 - including both chemical and mechanical (grinding)

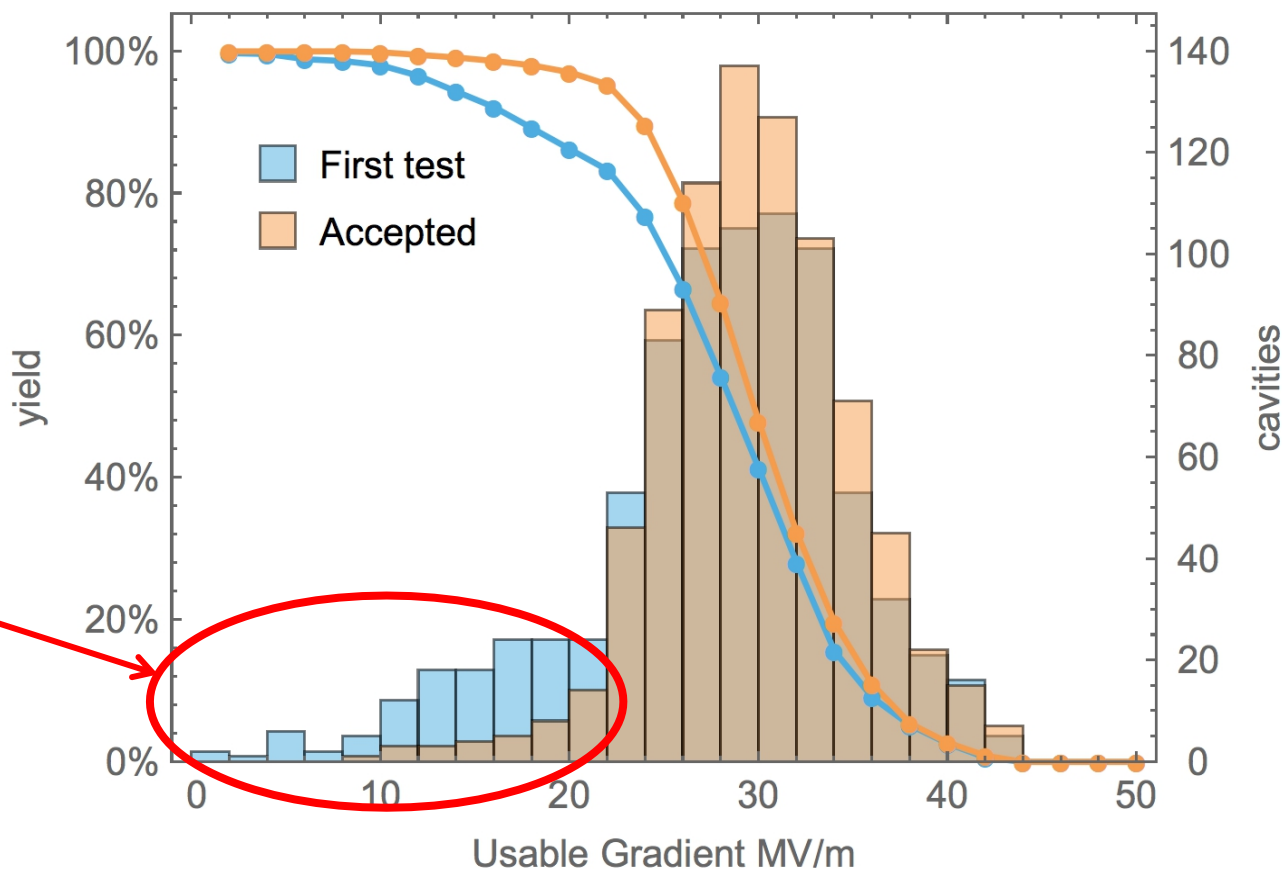


Final performance (sent for module assembly)

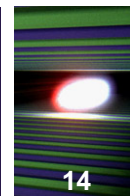


■ $\langle E_{\text{usable}} \rangle = 29.8 \pm 5.1 \text{ MV/m}$

impact of retreatment



As received Q_0 performance



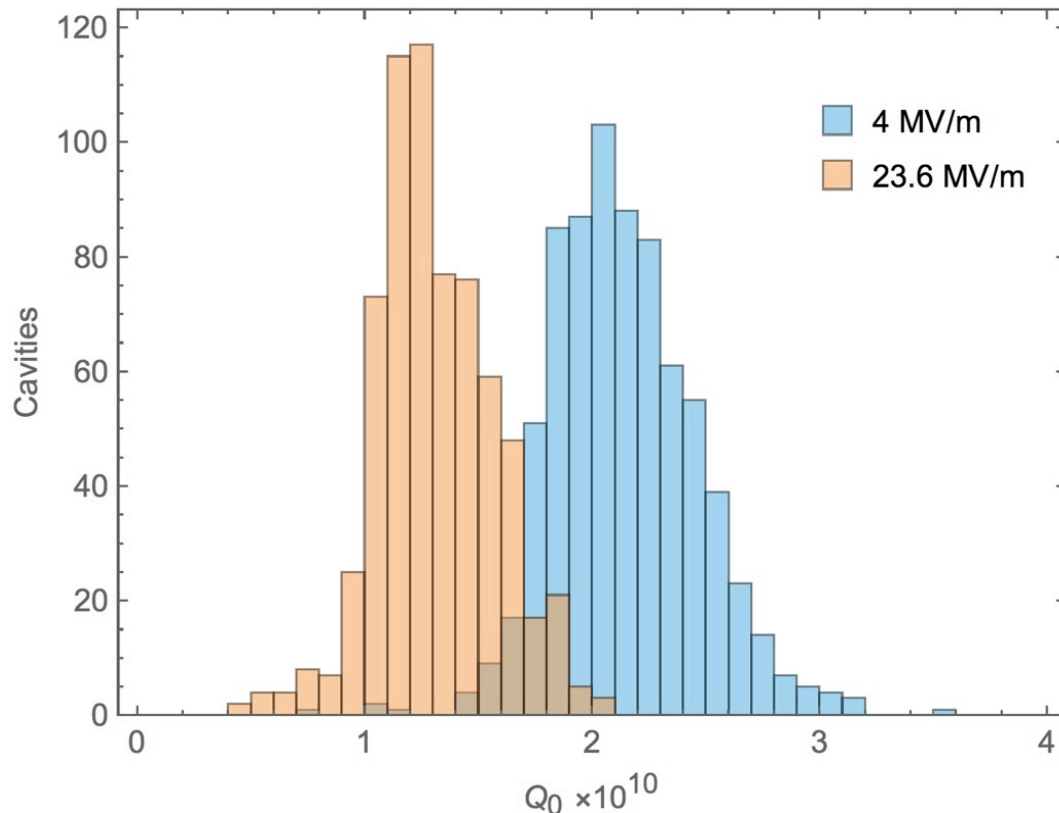
Average \pm RMS:

4 MV/m: $2.1 \pm 0.3 \times 10^{10}$

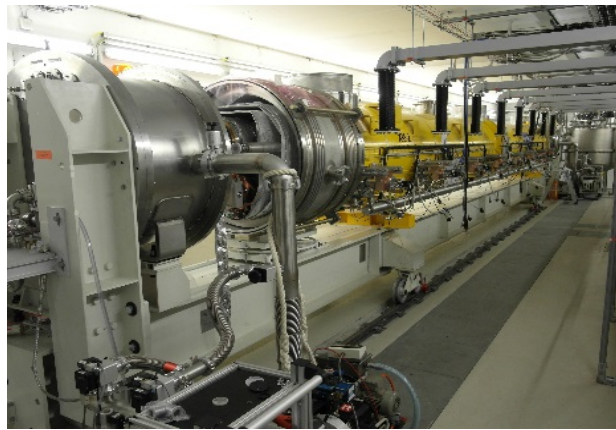
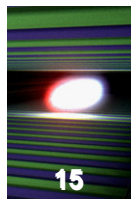
23.6 MV/m: $1.3 \pm 0.3 \times 10^{10}$

Estimated measurement
error 10-20%

XFEL spec: $\geq 10^{10}$



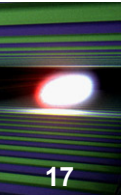
Cryomodule Test at AMTF




VT vs MT: Making Comparisons

	VT	MT	
Maximum gradient	No administrative limit	limited to 31 MV/m	<i>True impact unknown (but can set an upper limit)</i>
Field Emission (X-Ray)	Two monitors above and below cryostat	Two monitors upstream and downstream of cryomodule axis	<i>Different geometry / calibration makes exact comparison difficult</i>
Q_0	RF measurement	~1 hour 2K cryoload measurement with all cavities on resonance	<i>No Q_0 limit taken in MT definition of usable gradient.</i>
General	CW measurement	Pulse RF measurement (10% duty cycle)	<i>Systematic errors and uncertainties</i>

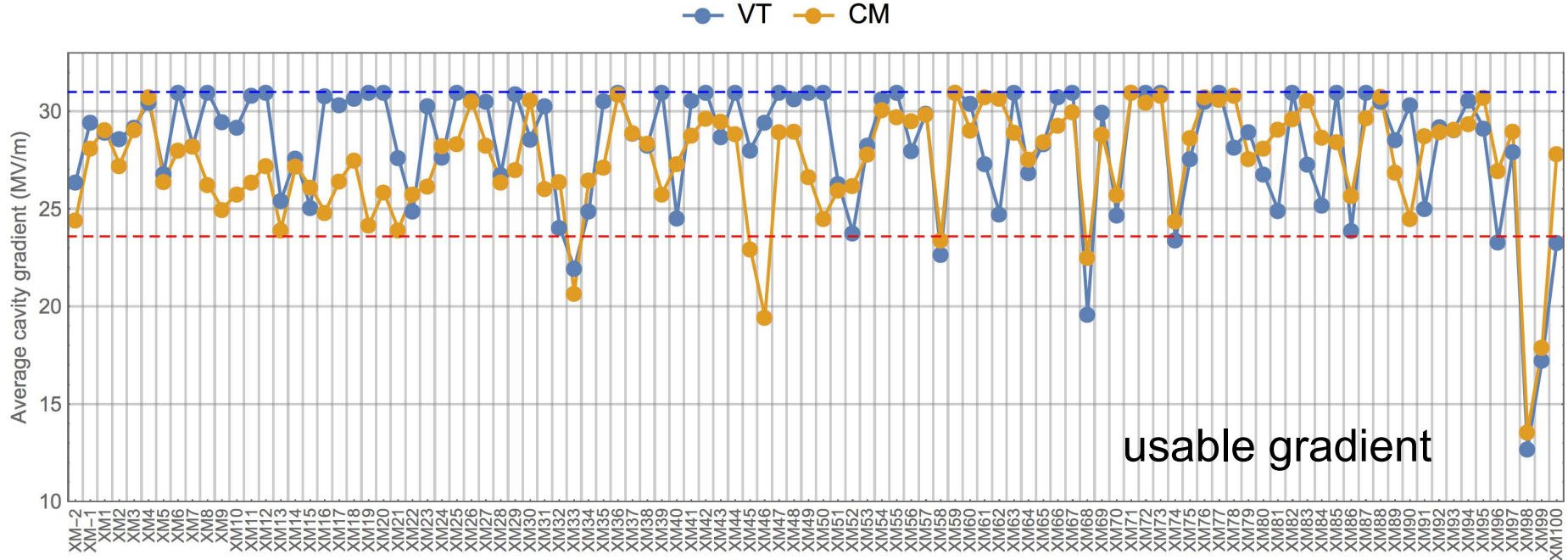
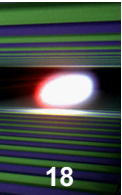
VT vs MT: Making Comparisons



	VT	MT	
Maximum gradient	No administrative limit	limited to 31 MV/m	<i>True impact unknown (but can set an upper limit)</i>
Field Em (X-Ray)	<p><i>when making comparisons,</i>  <i>geometry / n makes comparison</i></p>		
Q₀	RF measurement	1 hour 2K cryostat measurement with all cavities on resonance	<i>No Q₀ limit taken in MT definition of usable gradient.</i>
General	CW measurement	Pulse RF measurement (10% duty cycle)	<i>Systematic errors and uncertainties</i>

A quench (BD) below 31 MV/m can be compared

Cryomodule average gradient performance



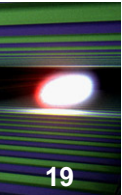
VT capped at 31 MV/m for fair comparison

~3% difference measured this way

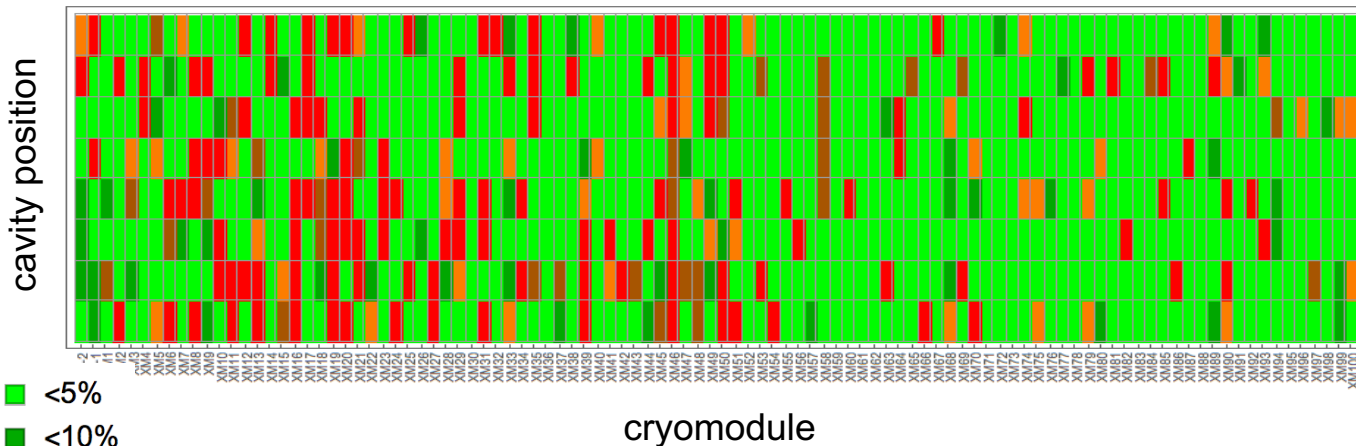
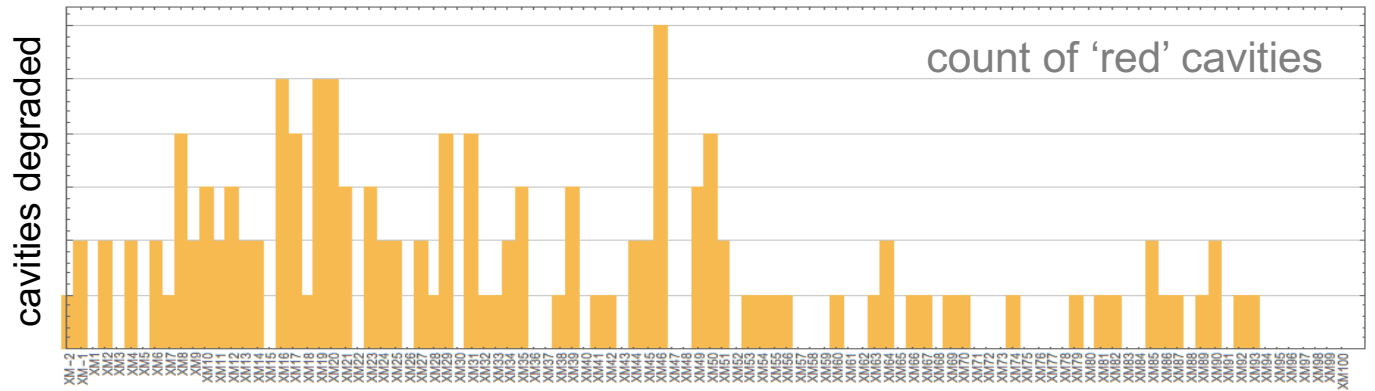
$3\% \leq \Delta G \leq 8\%$

	N_{cavs}	Average	RMS
VT	815	28.3 MV/m	3.5
CM	815	27.5 MV/m	4.8

Degradation matrix

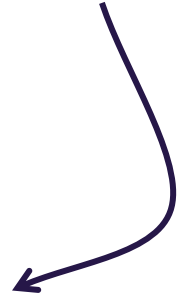
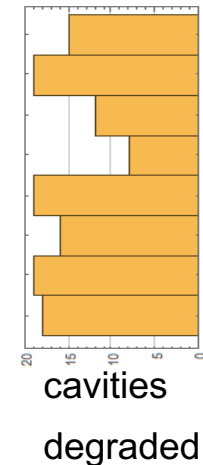


Degradation defined as $\geq 20\%$ (red)

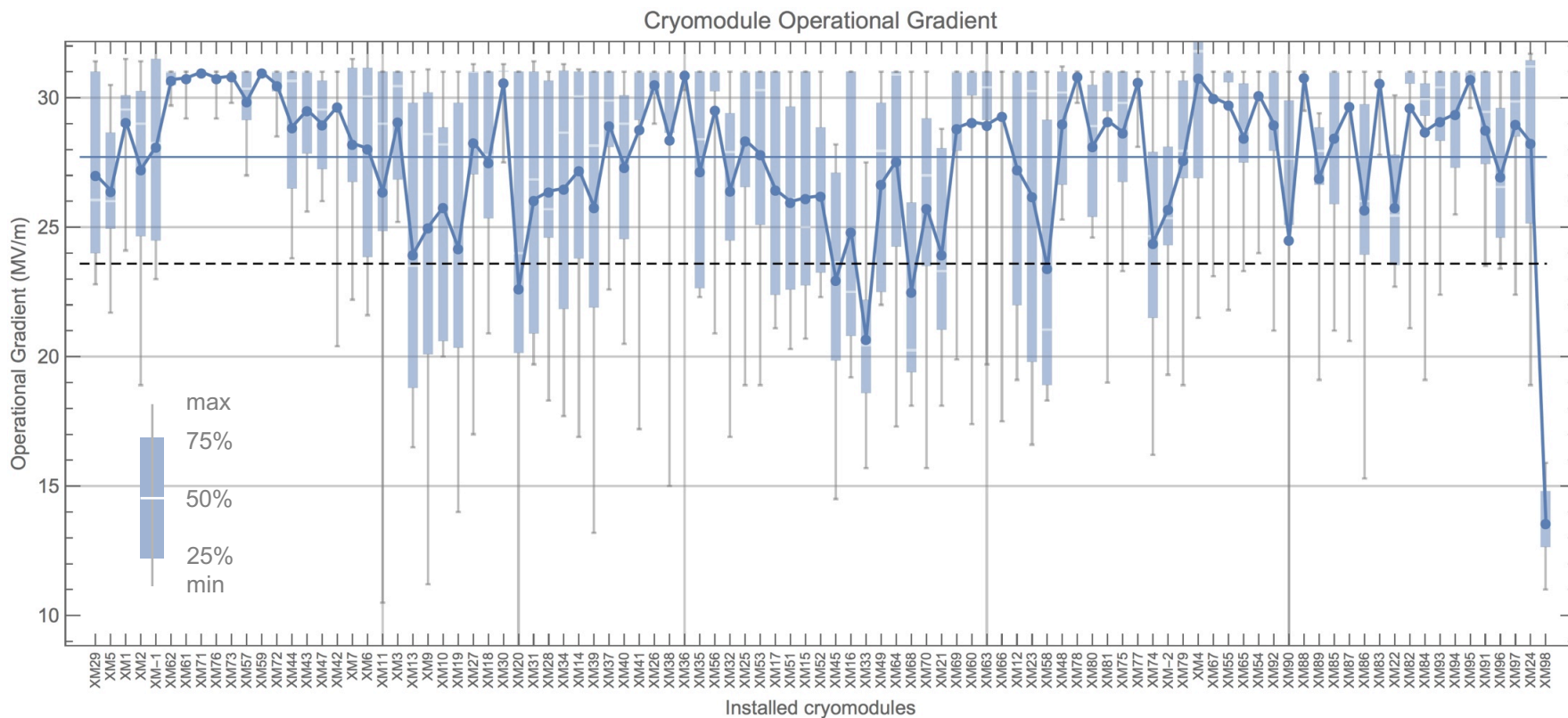


- <5%
- <10%
- <15%
- <20%
- $\geq 20\%$

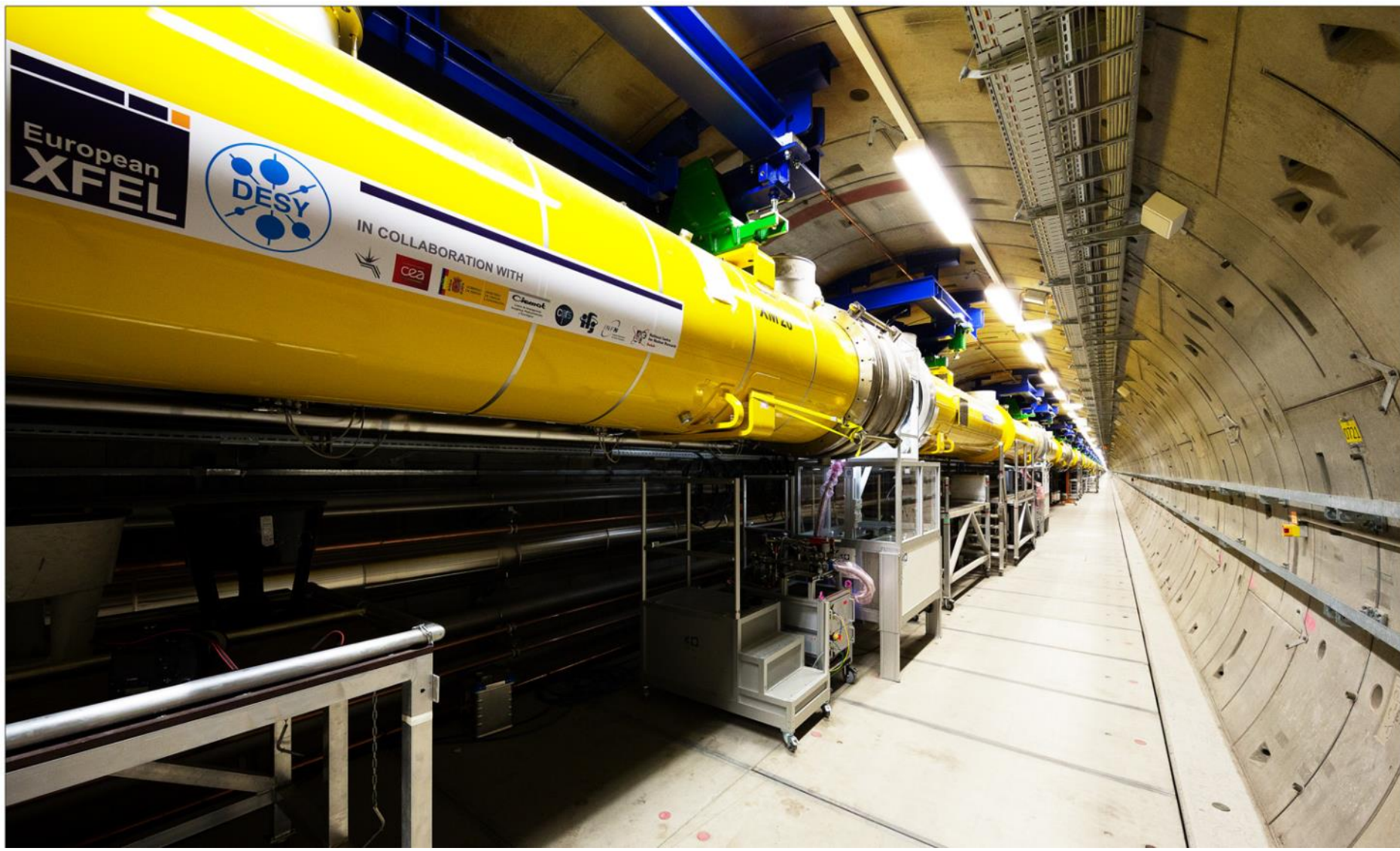
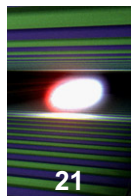
best place to be a happy cavity in a cryomodule



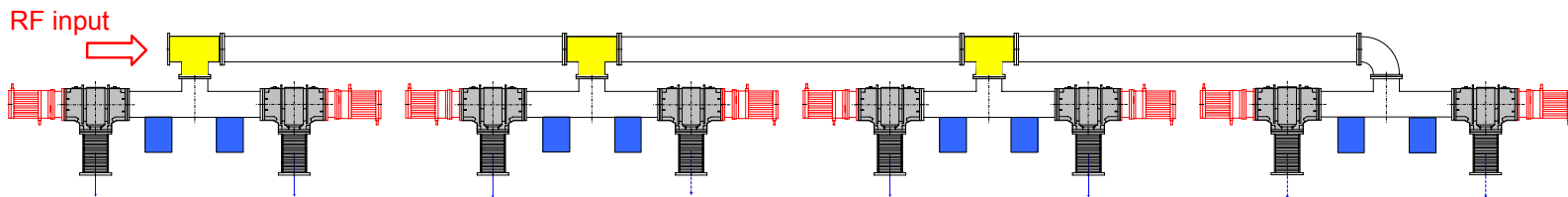
Cryomodule performance (AMTF module test)



Average (blue line) is good but spread within modules is still quite large
 → “Fine tuning” of waveguide distribution to maximise energy gain.

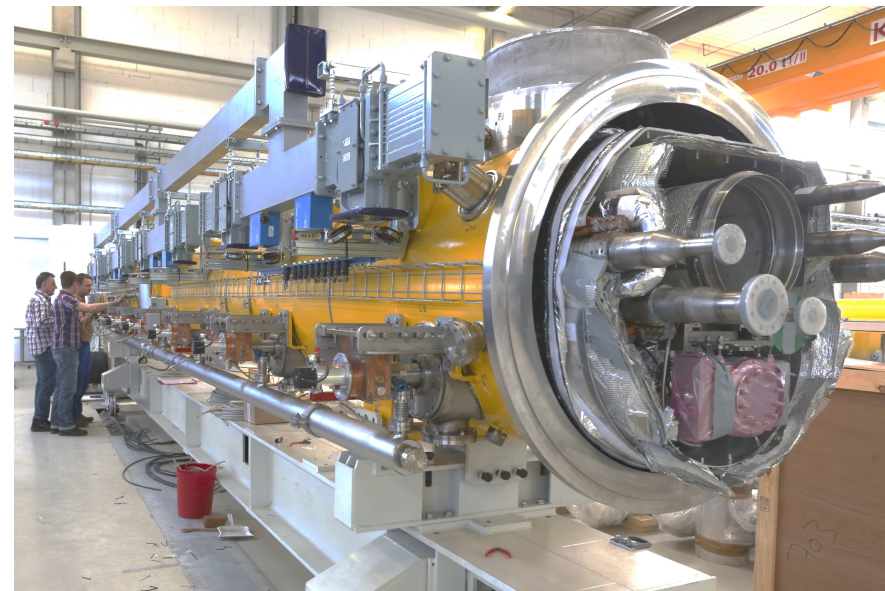


Impact of Waveguide Distribution (WD) system (Installed Gradient)



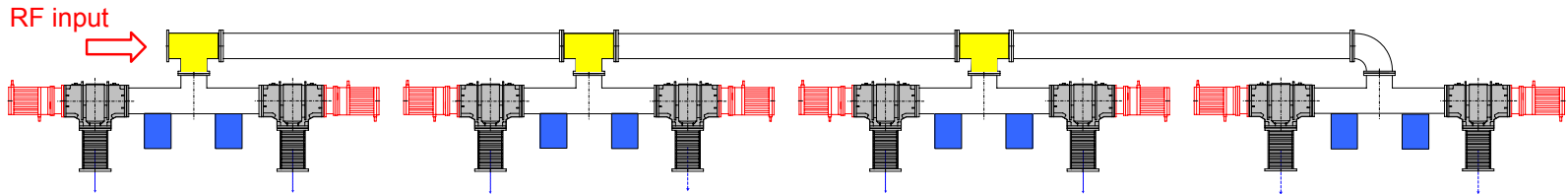
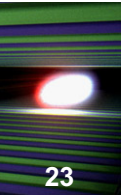
courtesy V. Katelev

- 1 10-MW klystron drives four modules (32 cavities)
- WD for cryomodules tailored for MT results
 - maximising voltage
 - up to 3dB difference between cavity pairs
- Allow up to 3dB split between adjacent cryomodule pairs
- Equal power output from two klystron arms



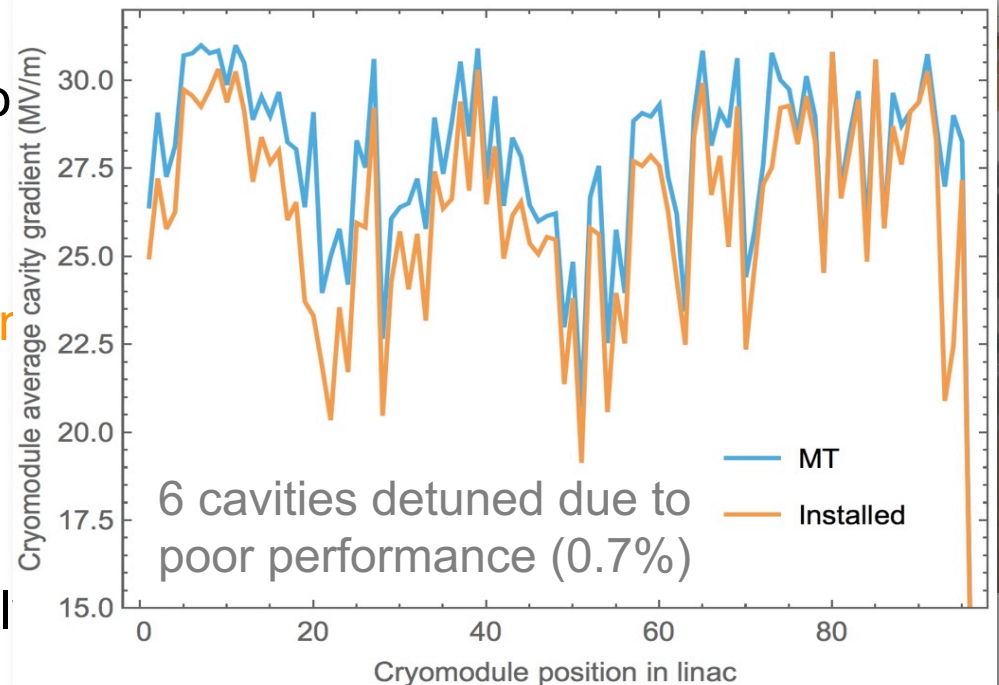
see THPLR067 Choroba, Katalev, Apostolov

Impact of Waveguide Distribution (WD) system (Installed Gradient)

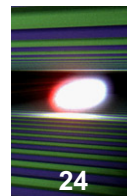


courtesy V. Katelev

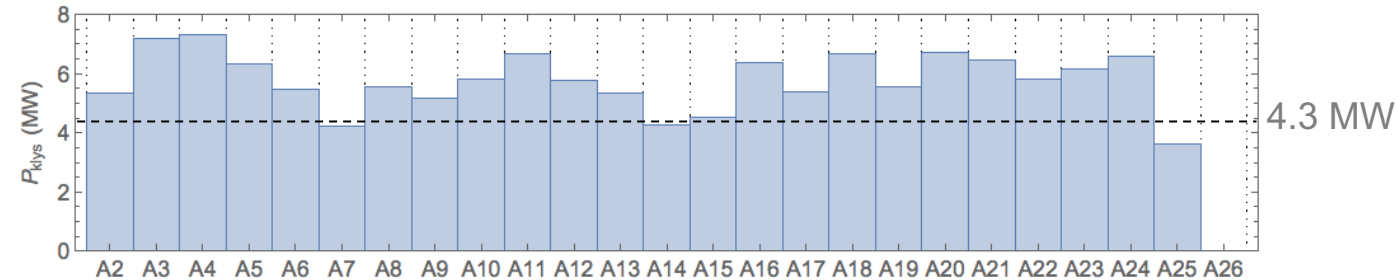
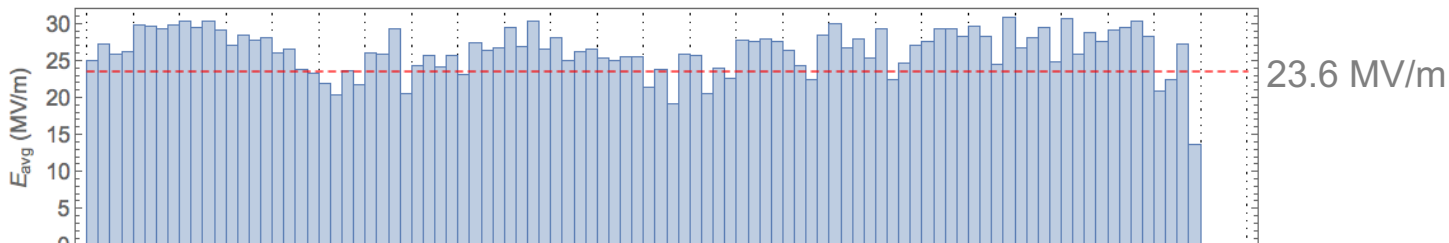
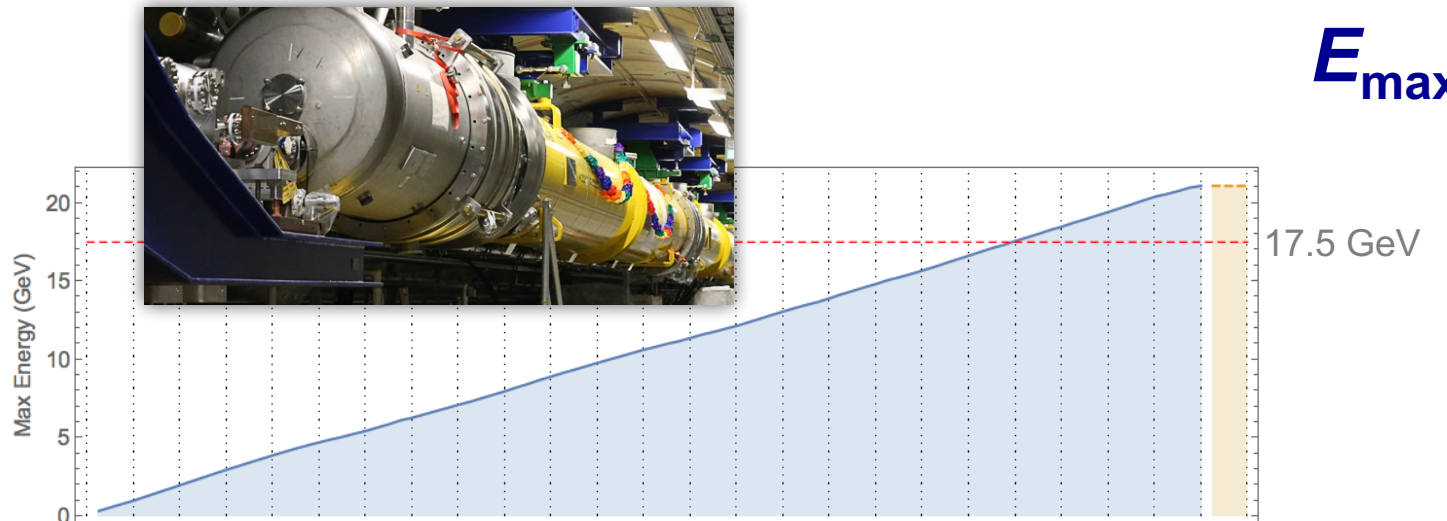
- 1 10-MW klystron drives four modules (32 cavities)
- WD for cryomodules tailored for results
 - maximising voltage
 - up to 3dB difference between cavity pairs
- Allow up to 3dB split between adjacent cryomodule pairs
- Equal power output from two klystron arms



Projected installed energy profile



$E_{\max} \sim 20 \text{ GeV}$



last RF station not installed
(4 cryomodules)

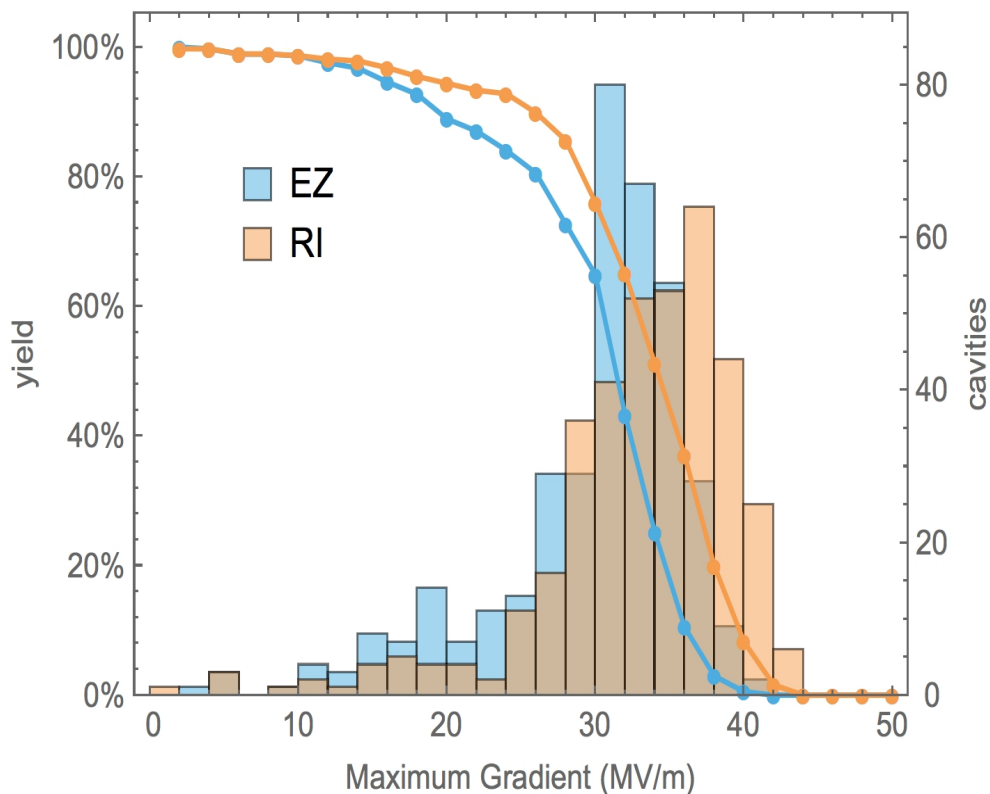
ILC specifications

Has XFEL achieved them?

(Discussing mostly VT performance)

- Vertical Test qualification
 - ≥ 35 MV/m with $Q_0 \geq 8 \times 10^9$
 - Installed
 - ≥ 31.5 MV/m with $Q_0 \geq 10^{10}$ (10% for degradation and operations margin)
 - Specification for gradient spread $\pm 20\%$
 - $28 \text{ MV/m} \leq g \leq 42 \text{ MV/m}$, $\langle g \rangle = 35 \text{ MV/m}$
 - Reinterpret VT Qualification as required
yield $\geq 28 \text{ MV/m}$ with $\langle g \rangle = 35 \text{ MV/m}$ ($Q_0 \geq 10^{10}$?)
 - First pass: 75%
 - Second pass: 90%
- } TDR cost model

'Final EP' vs 'Flash BCP'

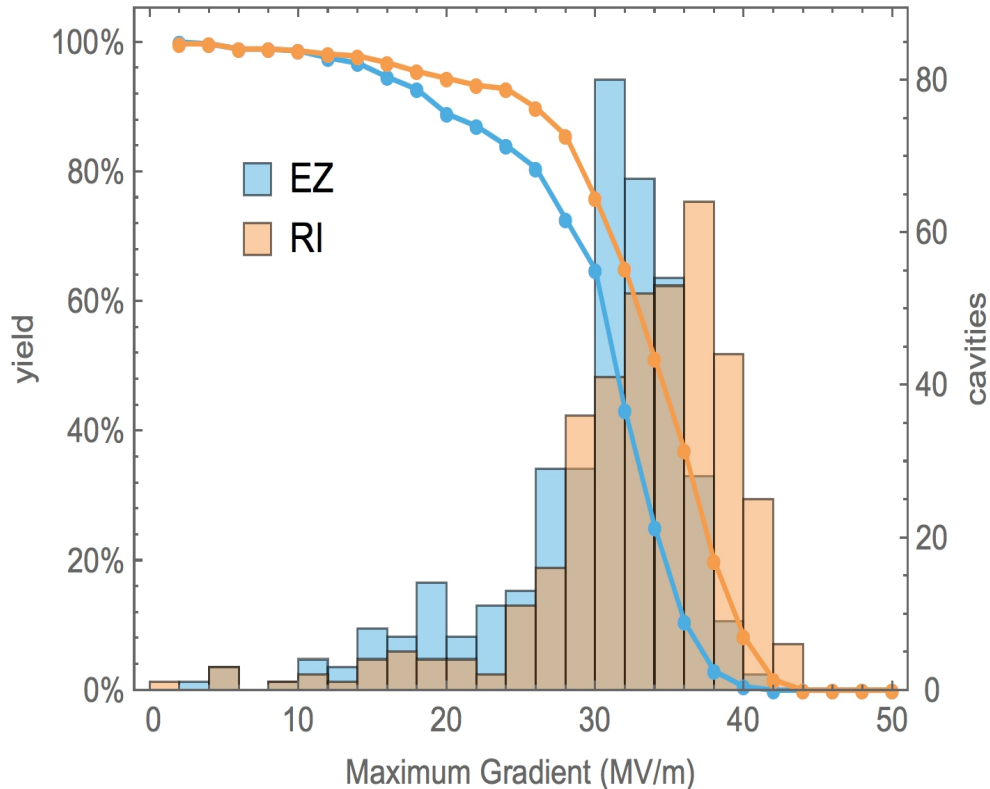


RI (Final EP)

	Max	Usable
Number of cavities	375	375
$\langle G \rangle$ [MV/m]	33.	29.
σ_G [MV/m]	6.6	7.4
$\langle G \rangle_{G \geq 28}$ [MV/m]	35.	33.3
Yield @20	94%	89%
Yield @28	86%	63%
Yield @35	44%	18%

- RI cavities showed ~10% improvement in average performance
 - Both max and usable
- Mostly attributed to high-field Q-slope associated with Flash BCP

'Final EP' vs 'Flash BCP'

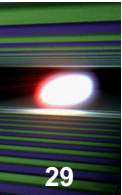


RI (Final EP)

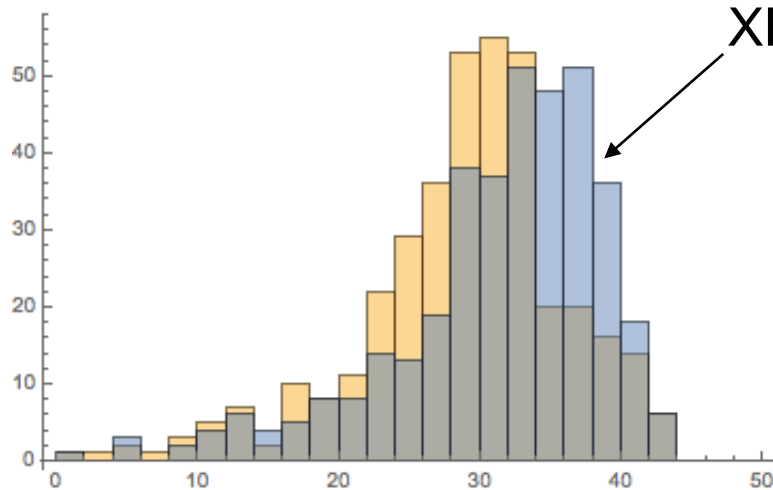
	Max	Usable
Number of cavities	375	375
$\langle G \rangle$ [MV/m]	33.	29.
σ_G [MV/m]	6.6	7.4
$\langle G \rangle_{G \geq 28}$ [MV/m]	35.	33.3
Yield @20	94%	89%
Yield @28	86%	63%
Yield @35	44%	18%

- RI cavities showed ~10% improvement in average performance
 - Both max and usable
- Mostly attributed to high-field Q-slope associated with Flash BCP

Usable field – ignore Q_0 ? (FE only)

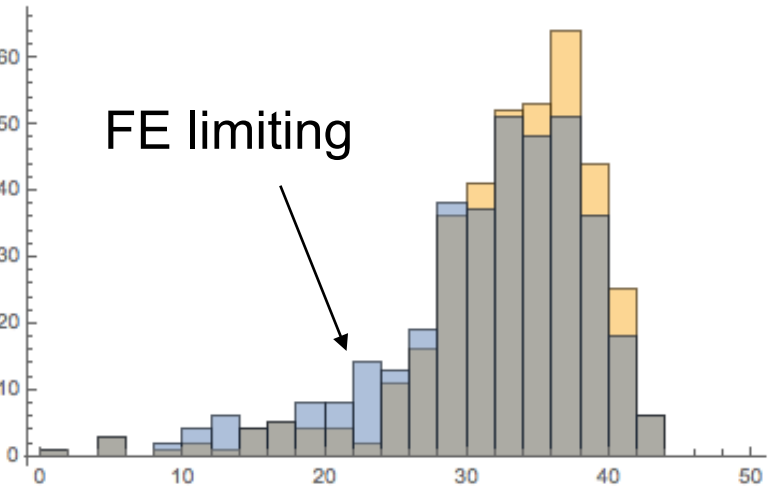


RF cavities only



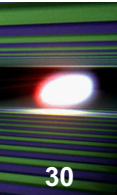
■ Usable (XFEL)
■ Usable (No Q0 limit)

	Max	Usable	usable No Q
Number of cavities	375	375	372
$\langle G \rangle$ [MV/m]	33.	29.	31.4
σ_G [MV/m]	6.6	7.4	7.5
$\langle G \rangle_{G \geq 28}$ [MV/m]	35.	33.3	34.7
Yield @20	94%	89%	91%
Yield @28	86%	63%	77%
Yield @35	44%	18%	37%



■ Max
■ Usable (No Q0 limit)

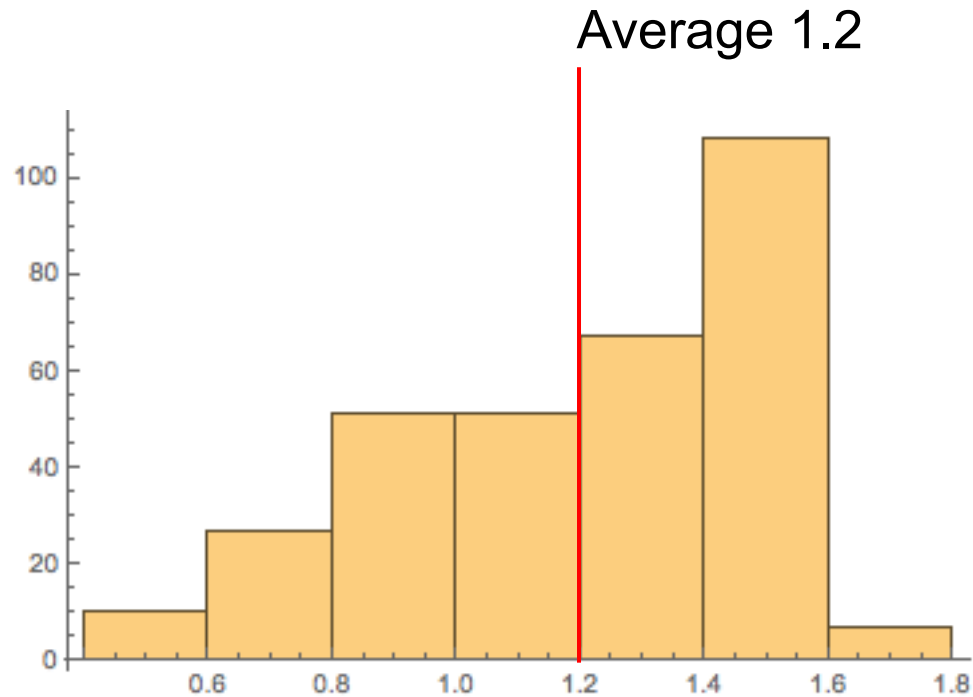
Cannot just ignore Q_0



30

Calculate g^2/Q_0 all cavities with $g \geq 28$ MV/m

Normalise to $35^2/10^{10}$



True first pass yield is between XFEL and 'no Q_0 ' limits (63% and 77%)

Second pass?

- No direct 'correct' comparison possible
 - Cut off for XFEL retreatment ≤ 20 MV/m
 - ILC is ≤ 28 MV/m
- Can try to use retreatment MC model based in XFEL results

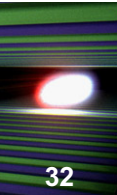
		ILC TDR (assumed)	XFEL	
			max	usable
First-pass	Yield >28 MV/m	75%	85%	63%
	Average >28 MV/m	35 MV/m	35.2 MV/m	33.5 MV/m
First+Second pass	Yield >28 MV/m	90%	94%	82%
	Average >28 MV/m	35 MV/m	35.0 MV/m	33.4 MV/m
First+Second+third pass	Yield >28 MV/m	-		91%
	Average >28 MV/m	-		33.4 MV/m

More re-treatments - but mostly only HPR

Number of average tests/cavity increases from 1.25 to 1.55 (1st+2nd) or

20% over-production or additional re-treat/test cycles

Lessons Learnt?



- TESLA technology has been successfully industrialised and can be mass produced
 - No reasons why this cannot be extrapolated to ILC numbers
- Success requires DILIGENCE (and attention to detail)
 - Close cooperation with cavity vendors
 - Constant feedback, QA and QC
- Standard 'TESLA' recipe can almost achieve ILC specifications
 - But improvement still needed
 - 30 MV/m average is great by 7 MV/m RMS spread is too large (why?)
 - Q_0 performance (Nitrogen anybody?)
- String assembly without degradation is not impossible
 - Again, requires diligence!
 - Auditing, QA/QC, feedback, etc.